Thermoelectric Hotspot Cooling Using Thermally Conductive Fillers

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Abstract

The commercial applications of thermoelectric coolers (TECs) are limited to niche markets owing to their low cooling efficiency. For hotspot cooling, in which the Fourier heat is added to the Peltier heat, thermoelectric (TE) materials should possess both large power factors and high thermal conductivities. However, the interdependence among TE material properties renders the development of such materials challenging. Herein, we provide a design strategy of TEC that addresses these material challenges at the device level. As proof of concept, we demonstrate that the cooling capability of filler-embedded TECs (F-TECs), which consist of TE legs with large power factors and a thermally conductive filler material, can be significantly improved compared to that of conventional TEC, owing to the 42.5% enhanced effective thermal conductance. Additionally, infrared imaging shows that the filler can decrease the temperature gradient and maximum temperature of the TE legs, which may improve the thermal stability of the TECs. Our proposed F-TEC concept can facilitate the development of effective TEC devices that can be widely used in hotspot cooling applications, such as in microprocessors, batteries and photovoltaic cells.
<table>
<thead>
<tr>
<th>Nomenclature</th>
<th>Definition</th>
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<tbody>
<tr>
<td>Bare</td>
<td>Conventional TEC without filler</td>
</tr>
<tr>
<td>BN0</td>
<td>Ecoflex–0wt.% BN composite or F-TEC using the composite as filler</td>
</tr>
<tr>
<td>BN23</td>
<td>Ecoflex–23wt.% BN composite or F-TEC using the composite as filler</td>
</tr>
<tr>
<td>BN33</td>
<td>Ecoflex–33wt.% BN composite or F-TEC using the composite as filler</td>
</tr>
<tr>
<td>COP</td>
<td>Coefficient of performance</td>
</tr>
<tr>
<td>$c_p$</td>
<td>Specific heat capacity (J/kg K)</td>
</tr>
<tr>
<td>$e$</td>
<td>Electron charge (C)</td>
</tr>
<tr>
<td>$I_p$</td>
<td>Electrical current intensity applied to the TECs or legs (A)</td>
</tr>
<tr>
<td>$I_{p,\text{Opt}}$</td>
<td>Optimal electrical current intensity for TEC operation (A)</td>
</tr>
<tr>
<td>$L$</td>
<td>Lorenz number ($V^2/K^2$)</td>
</tr>
<tr>
<td>$K$</td>
<td>Thermal conductance (W/K)</td>
</tr>
<tr>
<td>$K_{\text{Device}}$</td>
<td>Thermal conductance of the device including $K_{\text{TE}}$ and $K_{\text{Filler}}$ (W/K)</td>
</tr>
<tr>
<td>$K_{\text{Filler}}$</td>
<td>Thermal conductance of the filler (W/K)</td>
</tr>
<tr>
<td>$K_{\text{TE}}$</td>
<td>Thermal conductance of the TE legs (W/K)</td>
</tr>
<tr>
<td>$k_B$</td>
<td>Boltzmann constant (J/K)</td>
</tr>
<tr>
<td>$m^*$</td>
<td>Effective mass of the carrier (kg)</td>
</tr>
<tr>
<td>$n$</td>
<td>Carrier concentration ($m^3$)</td>
</tr>
<tr>
<td>PF</td>
<td>Power factor ($= \sigma S^2$) (W/(m·K^2))</td>
</tr>
<tr>
<td>$Q$</td>
<td>Heat transfer rate (W)</td>
</tr>
<tr>
<td>$Q''$</td>
<td>Heat flux (W/m^2)</td>
</tr>
<tr>
<td>$R_{\text{TEC}}$</td>
<td>Electrical resistance of the TEC (Ω)</td>
</tr>
<tr>
<td>$S$</td>
<td>Seebeck coefficient (V/K)</td>
</tr>
<tr>
<td>TE</td>
<td>Thermoelectric</td>
</tr>
<tr>
<td>TEC</td>
<td>Thermoelectric cooler</td>
</tr>
<tr>
<td>F-TEC</td>
<td>Filler-embedded (high-$K$) TEC</td>
</tr>
<tr>
<td>$T$</td>
<td>Absolute temperature (K)</td>
</tr>
<tr>
<td>$T_{\text{Heat}}$</td>
<td>Absolute temperature at the head-loaded side of the TEC (K)</td>
</tr>
<tr>
<td>$T_{\text{Sink}}$</td>
<td>Absolute temperature at the heat sink of the TEC (K)</td>
</tr>
</tbody>
</table>
\( \Delta T \)  
Temperature difference at the ends of the TEC defined as \( T_{\text{Heat}} - T_{\text{Sink}} \) (K)

\( \Delta T_{\text{Bare}} \)  
\( \Delta T \) of the Bare sample

\( \Delta T_{\text{BN33}} \)  
\( \Delta T \) of the BN33 sample

\( \nabla T \)  
Temperature gradient (K/cm)

\( T_{\text{Max, Legs}} \)  
Maximum temperature of the TE legs

\( zT \)  
Thermoelectric figure of merit

**Greek symbols**

\( \alpha \)  
Thermal diffusivity (mm\(^2\)/s)

\( \eta \)  
Degree of improved cooling performance by the filler defined as

\[
\Delta T_{\text{Bare}} - \Delta T_{\text{BN33}} \quad \text{(K)}
\]

\( \mu \)  
Carrier mobility (cm\(^2\)/V s)

\( \kappa \)  
Thermal conductivity (W/m K)

\( \kappa_{\text{ele}} \)  
Electron contribution on \( \kappa \) (W/m K)

\( \kappa_{\text{eff}} \)  
Effective thermal conductivity defined as

\[
\kappa_{\text{eff}} = \kappa + \frac{P \cdot F \cdot T_{\text{Heat}}^2}{2 \Delta T} \quad \text{(W/m K)}
\]

\( \kappa_{\text{Filler}} \)  
Thermal conductivity of the filler (W/m K)

\( \kappa_{\text{lat}} \)  
Lattice contribution on \( \kappa \) (W/m K)

\( \rho \)  
Mass density (kg/cm\(^3\))

\( \sigma \)  
Electrical conductivity (S/m)
1. Introduction

With the increasing miniaturization and densification of devices, the dissipation of localized heat has become a central issue in electronics, battery technologies, and photovoltaic cells [1–3]. According to various studies [4,5], a high heat flux exceeding 300 W/cm² can be generated at the hotspot of a microprocessor, which can cause a locally overheated region. To guarantee the performance and lifetime of devices that strongly depend on operating temperatures, these heat fluxes must be extracted instantly [3,6,7]. Although conventional convection-based cooling systems can dissipate such large heat fluxes, recent studies have pointed out that they can be inefficient in dissipating heat from small areas, in which handling zones are limited, owing to their bulky design and high thermal inertness [5,8,9]. In this regard, solid-state thermoelectric coolers (TECs) with various advantages can provide a suitable solution by applying the Peltier effect. These advantages include high-dynamic thermal transients (heat transfer rates), compact size, low weight, and the absence of mechanical moving parts and a working refrigerant; therefore, TECs are suitable for small-scale hotspot cooling [10–14]. However, despite the potential of TECs in heat-dissipation applications, their commercial use has been limited to niche markets because of their low cooling efficiencies [15].

The cooling efficiencies of TECs have been estimated using the coefficient of performance (COP), which generally depends on the thermoelectric (TE) figure of merit ($zT = \frac{\sigma S^2 T}{\kappa}$) of the constituent materials. Here, $\sigma$ is the electrical conductivity, $S$ is the Seebeck coefficient, $\kappa$ is the thermal conductivity comprising the electronic ($\kappa_{\text{el}}$) and lattice vibration ($\kappa_{\text{lat}}$) contributions, and $T$ is the absolute temperature [16]. To improve the cooling efficiency, $zT$ has been improved over the past decades by increasing the power factor (PF = $\sigma S^2$) or decreasing the $\kappa$ of TE materials [17]. A higher PF leads to an increase in the pumped heat by the Peltier effect owing to an increased $S$ or a lowered internal power dissipation if the $\sigma$ is increased. Lowering the $\kappa$ improves the COP of refrigeration owing to the decreased Fourier heat flux. In refrigeration [17], the temperature of the heat-loaded side $T_{\text{Heat}}$ is lower than that of the heat sink $T_{\text{Sink}}$ (usually at room temperature) (Fig. 1a), and the direction of the active Peltier heat flow ($SI_T T_{\text{Heat}}$) owing to an applied current $I_T$ through the TE legs is opposite to the direction of the passive Fourier heat flow ($K_{TE} \Delta T$, where $K_{TE}$ is the thermal conductance of the
TE legs and $\Delta T = T_{\text{Heat}} - T_{\text{Sink}}$). As a low $\kappa$ attenuates the backflow of Fourier heat that compensates for the Peltier heat, the use of $zT$ by incorporating the denominator $\kappa$ is justified as a criterion for determining the cooling efficiency. By contrast, in hotspot cooling [18,19], in which $T_{\text{Heat}}$ is higher than $T_{\text{Sink}}$, the Peltier heat flows in the same direction as the Fourier heat (Fig. 1b). Here, a low $\kappa$ decreases the Fourier heat transport by acting as a thermal barrier. Therefore, neither a high $zT$ nor COP guarantees a high heat-dissipation capability in this case [18,19]. This distinctive feature of hotspot cooling necessitates specific material properties and an adapted device design. However, most commercial TECs have been optimized to achieve a high $zT$ for refrigeration, which renders them a good thermal insulator (Fig. 1c). This optimization criterion has limited the widespread use of TECs for hotspot cooling conditions, which are found in most thermal management systems of electronics and batteries.

To address the aforementioned issue, Zebarjadi [18] highlighted the necessity of TE materials with a high $\kappa$ and large PF, which are contrary to traditional high-$zT$ materials. Adams et al. [19] and Li et al. [20] experimentally demonstrated TE hotspot cooling using high $\kappa$ materials combined with large PFs such as CePd$_3$, Co, and Cu-Ni alloys. Additionally, as a criterion for designing efficient hotspot cooling materials, the effective thermal conductivity was suggested and expressed as follows [19]: $\kappa_{\text{eff}} = \kappa + \frac{\text{PF} \cdot T_{\text{Heat}}^2}{2\Delta T}$, which includes the intrinsic thermal conductivity of the material and extrinsic PF-driven thermal conductivity. Nimmagadda and Sinha [21] used numerical simulations to study the TE properties required for transient on-chip cooling using a Si die. They determined that TE materials with a PF > 50 mW/m K$^2$ and $\kappa > 100$ W/m K are necessary to justify the use of TECs for on-chip hotspot cooling.

Despite the efforts to explore novel materials for hotspot cooling, the interdependence of $S$, $\sigma$, and $\kappa$ complicates the simultaneous optimization of PF and $\kappa$ of a material [22,23]. Specifically, $S$ is inversely proportional to $n^{2/3}$ according to [22] $S = \frac{8\pi^2k_B^2}{3eh^2}m^*T\left(\frac{\pi}{3n}\right)^{2/3}$ for metals, which are promising material candidates for hotspot cooling, under the parabolic band and energy-independent scattering approximations. Here, $n$ is the carrier concentration, $m^*$ is the effective mass of the carrier, $k_B$ is the Boltzmann constant, $e$ is the electron charge, and $h$ is
the Planck constant. Additionally, $\sigma$ is proportional to $n$ according to $\sigma = ne\mu$, where $\mu$ is the carrier mobility. Furthermore, $\kappa_{\text{ele}}$ is related to $n$ by the Wiedemann–Franz law \cite{16} $\kappa_{\text{ele}} = L\sigma T$ and thus is proportional to $n$, where $L$ is the Lorenz number. Therefore, PF ($\sigma^2$) can be optimized at a specific $n$ but $\kappa_{\text{ele}}$ cannot \cite{22}, rendering the simultaneous optimization of PF and $\kappa$ challenging.

As a way to circumvent such a material challenge, the efficiency of a TEC can also be improved by tailoring its structural design. In typical TECs for refrigeration, the gap between TE legs is filled with air or vacuum during operation, which allows most of heat flux to be conducted through the TE legs with low $\kappa$, making the overall device thermal conductance ($K_{\text{Device}}$) low. In contrast, for hot spot cooling, the gap between TE legs can be utilized as an additional thermal path to increase $K_{\text{Device}}$. For instance, the gap may be filled with an electrically-insulating and thermally-conducting filler material to provide an additional heat transfer channel (Fig. 1d). This strategy allows independent optimizations of $K_{\text{Device}}$ and PF, since $K_{\text{Device}}$ can be varied by filler design whereas PF can be optimized through TE material design.

In this study, we demonstrate a proof of concept of such a design strategy of TEC. For that, we fabricate a filler-embedded TEC (F-TEC) that consists of TE legs with high PFs and a high-$\kappa$ filler material. We show that the cooling efficiency of such F-TECs is significantly improved compared to that of conventional TEC, owing to the enhanced $K_{\text{Device}}$. We systematically investigate the role of a filler on the cooling efficiency of a single type of a Peltier cooler module by varying its $K_{\text{Device}}$ using various filler materials. Moreover, an infrared (IR) imaging is used to visualize the effect of the filler on the maximum temperature and temperature gradient in TE legs.
Fig. 1. Schematic of a thermoelectric cooler (TEC) used for (a) refrigeration and (b) hotspot cooling, in which the Peltier (SIP) and Fourier (KTEΔT) heat flows have the opposite or same directions, respectively. Here, S, IP, T, KTE, and ΔT are the Seebeck coefficient, electrical current applied to the Peltier, absolute temperature, thermal conductance of thermoelectric legs, and temperature difference between heat loaded (THeat) and sink sides (TSink), respectively. Additionally, Q” indicates the heat load required for heat dissipation. The effect of Joule heating is not shown for simplicity, each half of which is dissipated to the heat-loaded side and heat sink, respectively, for both cases. The corresponding optimized device structures with (c) low and (d) high device thermal conductance (KDevice) values. (d) Filler-embedded high KDevice TEC (F-TEC) proposed in this study.
2. Materials and methods

(a) Fabrication process of filler-embedded thermoelectric coolers (F-TEC).

(b) Photographs of the (b) classical thermoelectric cooler (TEC) without a filler and (c) F-TEC.

(d) X-ray diffraction patterns of the fillers. Additionally, $2\theta$ is corrected using the Si [111] peak (not shown in the figure). The inset depicts the main peaks of BN. (e) Backscattered electron and (f) energy-dispersive X-ray spectroscopy images of the filler containing 33 wt.% BN powder. (g) Thermal conductivity of the fillers ($k_{\text{Filler}}$). (h) Device thermal conductance ($K_{\text{Device}}$) measured and calculated based on the thermal conductance of the TE legs ($K_{\text{TE}}$) and
fillers \( (K_{\text{Filler}}) \) as a function of \( \kappa_{\text{Filler}} \). The device conductance of the F-TEC was compared to the starting value without a filler, which is indicated by the horizontal dashed line. (i) Electrical resistance \( (R_{\text{TEC}}) \) of the TECs. All transport data were acquired at 300 K.

2.1 Fabrication of filler-embedded thermoelectric cooler (F-TEC)

The F-TECs used for hotspot cooling were fabricated by filling the interior of a TEC with a polymer–ceramic composite (Fig. 2). We selected polymer–ceramic composites as the filler materials in this study for the following reasons. First, the thermal conductivities of polymer–ceramic composites depend on the type and concentration of the ceramic additive material \([24–27]\); therefore, they provide an ideal platform to control the thermal conductance of a device \( (K_{\text{Device}}) \) by changing the composition as an experimental variable. In this study, we systematically investigated the impact of filler on \( K_{\text{Device}} \) and on the resulting cooling performance of the device, instead of simply maximizing the \( K_{\text{Device}} \). Second, polymers do not cause significant thermal stress in the TECs during fabrication and cooling operations because of their elasticity and softness. Finally, polymers and ceramics are generally electrically insulating, which prevents electrical interference, such as shunting and electromagnetic heating, with the operation of TE legs. Commercially available polymer Ecoflex (Ecoflex 00-30, Smooth-on) and agglomerated BN powder (CFA 250S, 3M Co., Ltd.) were used as the constituents of the composite. Since the viscosity of a polymer–ceramic mixture rapidly increases with increasing the mass fraction of the ceramic component \([28,29]\), a polymer formulation with low viscosity is preferred in fillers. Ecoflex 00-30 was chosen because it possesses low viscosity \([30]\) and thus its composite mixtures are suitable for filling the complex inside the TECs (Figs. 1 and 2b). BN is an electrically insulating and thermally conductive material that is lightweight with a large energy band gap. Furthermore, BN is robust to oxidation and chemical reactions and exhibits high thermal stability \([25,26]\). The BN power used in this study was agglomerated and consequently thermally isotropic \([31]\).

The Ecoflex–BN composite samples were prepared by mixing the base and curing agents of Ecoflex in a 1:1 weight ratio (wt.%) (Fig. 2a). After vacuuming the Ecoflex mixture to remove pores, BN powders were added to the Ecoflex mixture in the mass fractions of 23 and 33 wt.% of the total mass, which includes both BN and polymer. Generally, a high ceramic
concentration imparts a high thermal conductivity to the resulting composite. In this study, 33 wt.% of BN was the maximum mass fraction of BN since higher concentrations become too viscous to firmly fill the complex inside the millimeter-sized TEC (Fig. 2b). Subsequently, commercial TECs (NL1010T-01AC, Marlow Industries Inc.) with a high PF and low $K_{\text{Device}}$ were dipped into the different Ecoflex–BN mixtures and vacuumed. The detailed structure of the TEC can be found in Fig. S1 in Supplementary Information. The F-TEC samples were cured at 393 K for 2 h and finally shaped into their original dimensions by cutting off the protruding parts of the solidified fillers (Figs. 2a and c). Four samples were used for this study, i.e., one reference TEC without a filler and three experimental F-TECs, which were prepared with Ecoflex fillers containing 0, 23, and 33 wt.% BN powder. These samples are labeled Bare, BN0, BN23, and BN33, respectively, according to the mass fraction of BN in the filler (Table 1).

Table 1. Thermal properties of the samples at 300 K (blanks: irrelevant properties).

<table>
<thead>
<tr>
<th>Sample label</th>
<th>BN concentration of the filler [wt.%]</th>
<th>Thermal conductivity of the filler $\kappa_{\text{Filler}}$ [W/m K]</th>
<th>Thermal conductance of the device $K_{\text{Device}}$ [mW/K]</th>
</tr>
</thead>
<tbody>
<tr>
<td>Bare</td>
<td>-</td>
<td>-</td>
<td>5.15</td>
</tr>
<tr>
<td>BN0</td>
<td>0</td>
<td>0.156</td>
<td>6.52</td>
</tr>
<tr>
<td>BN23</td>
<td>23</td>
<td>0.469</td>
<td>8.63</td>
</tr>
<tr>
<td>BN33</td>
<td>33</td>
<td>0.710</td>
<td>11.67</td>
</tr>
</tbody>
</table>

2.2 Structural analysis of filler

The crystal structures of the Ecoflex–BN composite fillers were investigated by measuring the X-ray diffraction (XRD) patterns using a combination of Cu-Ka1 and Ka2 radiation with an average wavelength of $\lambda = 1.5418$ Å (D2 phaser, Bruker). The polymer-based samples may cause a significant misalignment in the XRD measurements owing to sample warping and elasticity; therefore, the fillers were carefully molded to maintain a flat surface,
and crystalline Si powder was sprinkled onto the samples to correct the misalignment-induced 20 shift (See ref. [32] for the technical details). In addition, the 20, based on wavelength $\lambda = 1.5418$ Å, was converted to the commonly used 20 based on Cu-Kα1 with $\lambda = 1.5406$ Å. The microstructures of the Ecoflex–BN composites were investigated using the back-scattered electron mode in field emission scanning electron microscopy (JSM-IT800HL, JEOL) combined with energy-dispersive X-ray spectroscopy (EDS).

2.3 Thermal and electrical properties of filler and F-TEC

The thermal conductivity of each filler $\kappa_{\text{Filler}}$ was obtained by multiplying the thermal diffusivity $\alpha$, mass density $\rho$, and specific heat $c_p$ as follows: $\kappa_{\text{Filler}} = \alpha \times \rho \times c_p$ [33]. The Ecoflex–BN composites were carefully molded into 12.7 mm diameter disks for measuring $\alpha$. The samples were coated with a graphite spray (Graphit-33, Kontakt Chemie), and $\alpha$ was measured by laser flash analysis (LFA 467, Netzsch), during which the temperature was increased from 300 to 400 K in 20 K increments. This corresponded to the temperature range required for the active cooling experiment described in Section 3 (Fig. 3). The densities of the composites were obtained using Archimedes’ method (XS105, Mettler Toledo) at room temperature (295 K), and the specific heat was measured using differential scanning calorimetry (Q200, TA instruments) while increasing the temperature from 300 to 400 K at a heating rate of 5 K/min.

The $K_{\text{Device}}$ values of the F-TECs were evaluated via the steady-state method [33] using a customized liquid nitrogen cryostat system (Lake Shore Cryotronics, Inc.) according to $Q = K_{\text{Device}} \Delta T$ with $Q$ being the heat flow rate and $\Delta T$ the temperature difference across the sample (Fig. 3a). Two T-type thermocouples for measuring $\Delta T = T_{\text{Heat}} - T_{\text{Sink}}$ were attached to the heat spreaders at the heat-loaded side ($T_{\text{Heat}}$) and at the heat sink ($T_{\text{Sink}}$) using silver epoxy (H20E, EPO-TEK). Here, Cu and constantan wires with a diameter of 25.4 µm (SPCP- and SPCI-001-50, Omega Engineering, Inc.) were used to form thin thermocouples to minimize heat losses along the wires. Subsequently, a 1000 Ω resistive heater (SGD-7/1000-LY13, Omega Engineering, Inc.) was connected using wires with a diameter of 76.2 µm. The heat flow rate
was determined according to \( Q = I_H V_H \) with \( I_H \) being the supplied electric current to the heater and \( V_H \) the corresponding voltage drop measured by a multimeter (2000, Keithley). The heater was attached to a BeO heat spreader with high thermal conductivity (\( \kappa \sim 300 \text{ W/(m K)} \) [34]) and subsequently placed on the top of TEC with thermal grease in between (H grease, Apiezon) to improve the thermal contact resistance and to homogenize the temperature distribution and heat flux at the hot side of the TEC. The thermocouple voltages for measuring \( T_{\text{Heat}} \) and \( T_{\text{Sink}} \) were monitored using a nanovoltmeter (2182A, Keithley) while applying \( I_H = 3 \) mA to the heater using a current source (6221, Keithley). The \( T_{\text{Sink}} \) was maintained at 300 K during the measurement. All measurements were conducted in the cryostat under a high vacuum of \( \sim 10^{-4} \text{ Pa} \) and under the cover of a gold-plated radiation shield to minimize heat losses by convection and radiation, respectively. These heat losses were consequently not considered for the determination of \( K_{\text{Device}} \).

3. Experimental results and discussion

3.1 Structural analysis of filler

First, the crystal structure of the fillers was investigated to verify that the thermally conductive BN was well embedded into the polymer as a form of composite. The XRD patterns in Fig. 2d revealed a clear BN peak, which increased with increasing the mass fraction of BN, while BN0 (Ecoflex) exhibited a broad peak that indicated an amorphous structure of the polymer. The backscattered electron image in Fig. 2e shows that the lighter elements B and N appear to be dark compared with the bright area of Ecoflex matrix with the heavier element Si. The composition of the dark dots was verified to be B and N using the corresponding EDS maps (Fig. 2f). These results indicated the absence of a chemical reaction between BN and Ecoflex for the fabrication process.

3.2 Controlling the thermal properties of filler and F-TEC

Next, we investigated the effect of the concentration of embedded BN on the thermal properties of the Ecoflex–BN composites. Figure 2g shows that \( \kappa_{\text{Filler}} \) at 300 K is 0.156, 0.469,
and 0.710 W/m K for BN0, BN23, and BN33, respectively. The maximum concentration of BN33 provides an overall increase of thermal conductivity of 355% compared to pure Ecoflex (BN0). The results are summarized in Table 1, while details including the thermal diffusivity $\alpha$, density $\rho$, specific heat $c_p$, and temperature dependence of $\kappa_{\text{Filler}}$ can be found in Fig. S2 in Supplementary Information.

Then, we quantified the effect of the composite fillers on $K_{\text{Device}}$. As shown in Fig. 2h, $K_{\text{Device}}$ monotonically increases with increasing thermal conductivity of the filler $\kappa_{\text{Filler}}$. BN33 exhibited the highest $K_{\text{Device}}$ of 11.67 mW/K at 300 K, which was 127% higher than that of Bare ($K_{\text{TE}} = 5.15$ mW/K). The measured $K_{\text{Device}}$ was in good agreement with its calculated counterpart, which was determined under the assumption of a parallel thermal connection[33] between the TE legs and the filler (i.e., $K_{\text{Device}} = K_{\text{TE}} + K_{\text{Filler}}$). $K_{\text{TE}}$ was kept constant for all calculations, while $K_{\text{Filler}}$ was estimated using $\kappa_{\text{Filler}}$ and the TE fill factor (~24%), which is the fractional area coverage of the TE legs per unit substrate area [35]. Furthermore, evaluating results for the sample Bare (without filler) at 300 K with $K_{\text{Device}} = K_{\text{TE}} = 5.15$ mW/K revealed a thermal conductivity $\kappa_{\text{TE}} = 1.91$ W/m K for the TE legs, which is in good accordance with typical values reported for Bi–Te-based TE materials [36–38]. The deviation between the measured and calculated values may be attributed to uncontrolled pores in the filler in the TEC or the thermal contact resistance between the filler and TEC, which were neglected for the $K_{\text{Device}}$ calculation. The temperature-dependent $K_{\text{Device}}$ data are presented in Fig. S3 for the range 300–400 K.

Although thermocouples and heater wires attached for $K_{\text{Device}}$ measurement (See Section 2 for details) have small diameters of 25.4 and 76.2 $\mu$m, respectively, heat loss through the wires was inevitable and resulted in an overestimation of the applied $Q''$ and $K_{\text{Device}}$. It is noted that the total thermal conductance of the attached wires lies in the range 0.140–0.186 mW/K, which equals a few percentages of $K_{\text{Device}}$ whose maximum value is 3.6% for Bare. The standard uncertainty of thermocouple voltage measurements is typically less than 0.2% and has a maximum of 0.38%, estimated from the standard deviation of twenty-five repeated measurements.
To verify whether the thermoelectric properties of the TE legs are affected by the embedding of the fillers, we measured the electrical resistance $R_{\text{TEC}}$ of the samples using the four-probe [39] and Delta mode measurements [40] (6221/2182A, Keithley) at 300 K in the cryostat. The standard measurement uncertainty was determined to be less than 0.001%. Figure 2g displays the $R_{\text{TEC}}$ values of the TEC and F-TEC samples, which are in the range 744–777 mΩ with a standard deviation of 11.7 mΩ. As the $R_{\text{TEC}}$ values of three different Bare samples were in the range 761–791 mΩ with a similar standard deviation of 12.4 mΩ (Fig. S4), we consider that the deviation of the $R_{\text{TEC}}$ values for F-TEC samples was neither caused nor influenced by the degradation of the TE legs during fabrication and measurement but just a result of typical manufacturing tolerances. These results indicated that the thermal conductance of the device can be separately optimized at the device level without significantly affecting the thermoelectric properties by embedding the interior of the TEC with thermal fillers. In the following sections, we discuss the improvement in the cooling performances of the F-TECs owing to the $K_{\text{Device}}$ enhanced by the fillers.

3.3 Evaluation of the heat-dissipation capabilities of the F-TECs

Fig. 3. (a) Experimental configuration for evaluating cooling performance. Temperature difference between the heat-loaded side and the heat sink under the heat flux $Q''$ of (b) 56
250, (c) 17 380, and (d) 0 W/m². (e) Temperature difference as a function of device thermal resistance (1/KDevice). All data were acquired at $T_{\text{Sink}} = 300$ K.

The cooling performance of the F-TECs was evaluated by monitoring the temperature difference $\Delta T$ between the heat-loaded $T_{\text{Heat}}$ and sink $T_{\text{Sink}}$ sides ($\Delta T = T_{\text{Heat}} - T_{\text{Sink}}$) at $T_{\text{Sink}} = 300$ K (Fig. 3). $\Delta T$ was measured using the thermocouples in the cryostat (Section 2). The measurements have been conducted under various heat fluxes that corresponded to different operation modes such as hotspot cooling ($Q'' = 56 250$ W/m² in Fig. 3b), refrigeration ($Q'' = 0$ W/m² in Fig. 3d), and at intermediate conditions ($Q'' = 17 380$ W/m² in Fig. 3c) (Refer to Fig. 1 and Introduction for details). An electrical current $I_P$ was applied to the TECs by a current source (E3546A, Agilent) in the range $0$–$1.2$ A in $0.2$ A increments. The TECs exhibited the best performance at $I_P = 1$ A; a further increase in $I_P$ caused the cooling performance to degrade owing to Joule heating.

First, we discuss the cooling performance at $Q'' = 56 250$ W/m² that corresponds to the hotspot cooling situation for all $I_P$ values. As shown in Fig. 3b, $\Delta T$ decreases in F-TECs compared to the classical TEC owing to the increased Fourier heat conduction due to the filler. When no current was applied ($I_P = 0$ A), at which the Peltier effect was absent and Fourier conduction dominated (Fig. S5), $\Delta T$ decreased from $131.24$ K for Bare ($\Delta T_{\text{Bare}}$) to $64.616$ K for BN33 ($\Delta T_{\text{BN33}}$). When $I_P = 1$ A was applied, at which the Peltier effect delivered the highest cooling performance and dominated (Fig. S5), $\Delta T$ decreased from $\Delta T_{\text{Bare}} = 31.599$ K to $\Delta T_{\text{BN33}} = 16.764$ K. The degree of improved cooling performance by the filler, defined as $\eta = \Delta T_{\text{Bare}} - \Delta T_{\text{BN33}}$, decreased while the increase in $I_P$ decreased the contribution of Fourier conduction compared to that of the Peltier effect (Refer to Fig. S5 for the quantitative analysis). In this case, the filler-induced high $K_{\text{Device}}$ improved the cooling performance by providing an additional heat path that contributed to Fourier conduction. Next, we investigated the cooling performance under $Q'' = 0$ W/m² that corresponded to refrigeration, in which the direction of the Fourier heat flow was opposite to that of the Peltier heat flow. In contrast to hotspot cooling, $|\Delta T_{\text{BN33}}|$ was smaller than $|\Delta T_{\text{Bare}}|$ for all $I_P$ values. In this case, the filler-induced high $K_{\text{Device}}$ degraded the cooling performance by increasing Fourier conduction, which compensated for the Peltier effect. Lastly, we demonstrated the case of $Q'' = 17 380$ W/m², wherein both hotspot cooling and refrigeration modes occur depending on the value of $I_P$ (Fig. 3c). At low $I_P$, hotspot
cooling is at work, while refrigeration occurs at high \( I_P \). The F-TECs performed better than the
Bare sample in hotspot cooling (where \( I_P \) \( \sim \) 0.3 A), whereas the performances of the F-TECs were worse than that of the Bare sample in refrigeration (where \( I_P \) \( \sim \) 0.3 A). This coincided with the results obtained from the previous cases. To further clarify that the improved and degraded cooling performances for the hotspot cooling and refrigeration situations, respectively, originated from the filler-induced \( K_{\text{Device}} \) engineering, we plotted \( \Delta T \) at \( I_P = 0 \) and 1 A as a function of the device thermal resistance \( 1/K_{\text{Device}} \) (Fig. 3e). The fitted lines in Fig. 3e indicate that \( \Delta T \) increases linearly with the increase in \( 1/K_{\text{Device}} \) for hotspot cooling and refrigeration. The minimum coefficient of determination (adjusted \( R^2 \)) of the fitted curves was 0.99713 for \( I_P = 0 \) A and 0.98739 \( I_P = 1 \) A, which implied that the increased \( K_{\text{Device}} \) directly improved and degraded the cooling performances of the TECs in hotspot cooling and refrigeration situations, respectively, without substantially affecting the thermoelectric properties of the TE legs. The deviation in \( \Delta T \) from the fitted lines, which was especially relatively large for \( I_P = 1 \) A, possibly occurred from the slight differences in \( R_{\text{TEC}} \) values (Fig. 2i).

We anticipate that the increased thermal conductance in F-TECs demonstrated in this study could offer broader applications beyond the low heat flux range of \( \sim 10^4 \) W/m² studied here. Specifically, this approach may be applicable to high heat flux ranges of \( \sim 10^6 \) W/m² relevant for electronic device cooling [4,5]. To further explore this potential, we calculated the cooling performance of (F-)TEC under the heat flux of \( Q'' = 3 \times 10^6 \) W/cm² as a function of device thickness, as shown in Fig. S6 in the Supplementary Information. As the device thickness decreases to \( \sim 50 \) μm, a typical thickness of TE tin films that can be fabricated using various deposition techniques [5,13], the F-TEC with high \( K_{\text{Device}} \) still exhibits superior performance with \( T_{\text{Heat}} = 329 \) K compared to TEC without filler (\( T_{\text{Heat}} = 350 \) K). Overall, our findings suggest promising opportunities for improving the performance of TE devices for a range of applications, including high heat flux electronic device cooling.

Even though most applications that require substantial heat dissipation are hotspot cooling situations [5,41], in which the proposed F-TECs can be advantageous, one may expect to develop a universal F-TEC that can be applied to all cooling situations, including hotspot cooling, refrigeration, and their intermediate. To achieve this, we may introduce a filler that has a large \( K_{\text{Filler}} \) for \( T_{\text{Heat}} > T_{\text{Sink}} \) (for hotspot cooling) and a small \( K_{\text{Filler}} \) for \( T_{\text{Heat}} < T_{\text{Sink}} \) (for
refrigeration). In particular, thermal diode materials and structures [42–44] can be suitable fillers as their thermal conductivities can be modulated using a magnetic field [32,45], electric field [46,47], and thermal energy [48].

3.4 COP and effective thermal conductance of the F-TECs in hotspot cooling

The COP, defined as the heat dissipation from the heat-loaded side $Q_{\text{Heat}}$ per input electrical power $P_{\text{Sup}}$, has been used to evaluate the cooling efficiency of TECs

$$\text{COP} = \frac{Q_{\text{Heat}}}{P_{\text{Sup}}}$$ (1)

The heat dissipation from the heat-loaded side can be determined by a net energy balance (Fig. 1a and 1b):

$$Q_{\text{Heat}} = S_{\text{TEC}} T_{\text{Heat}} I_p + K_{\text{Device}} (T_{\text{Heat}} - T_{\text{Sink}}) - \frac{1}{2} I_p^2 R_{\text{TEC}}$$ (2)

From the first law of thermodynamics, input electrical power can be defined as $P_{\text{Sup}} = Q_{\text{Heat}} - Q_{\text{Sink}}$, the difference between the heat dissipations from the heat-loaded side and to the heat sink $Q_{\text{Sink}}$, and expressed as

$$P_{\text{Sup}} = I_p^2 R_{\text{TEC}} - S_{\text{TEC}} I_p (T_{\text{Heat}} - T_{\text{Sink}})$$ (3)

Combining Eqs. (1)–(3), the COP can be expressed as

$$\text{COP} = \frac{S_{\text{TEC}} T_{\text{Heat}} I_p + K_{\text{Device}} (T_{\text{Heat}} - T_{\text{Sink}}) - \frac{1}{2} I_p^2 R_{\text{TEC}}}{I_p^2 R_{\text{TEC}} - S_{\text{TEC}} I_p (T_{\text{Heat}} - T_{\text{Sink}})}$$ (4)

As mentioned in the Introduction, the COP is a good indicator to evaluate the cooling efficiency in refrigeration. However, in hotspot cooling, the COP cannot be applied as in the refrigeration case, since the portion of Fourier heat flux $K_{\text{Device}} (T_{\text{Heat}} - T_{\text{Sink}})$ leads to an infinite COP at $I_p = S(T_{\text{Heat}} - T_{\text{Sink}}) / R_{\text{TEC}}$, according to Eq. (4). For a detailed discussion on the limitations of using COP in a hotspot cooling scenario, refer to the Section S7 of the Supplementary Information. Accordingly, we present the cooling efficiency of the TECs in
hotspot cooling by means of effective thermal conductance $K_{\text{TEC}}^{\text{Eff}}$, proposed by Adams et al. [19]. The $K_{\text{TEC}}^{\text{Eff}}$ captures the maximum heat dissipation of TECs $Q_{\text{Heat}}^{\text{Max}}$ at an optimal current $I_p^{\text{Opt}}$. By taking the derivative of Eq. (2), the optimal current and maximum heat dissipation can be determined as

$$I_p^{\text{Opt}} = \frac{S_{\text{TEC}}T_{\text{Heat}}}{R_{\text{TEC}}}$$  \hspace{1cm} (5)

$$Q_{\text{Heat}}^{\text{Max}} = (K_{\text{Device}} + \frac{(S_{\text{TEC}}T_{\text{Heat}})^2}{2R_{\text{TEC}}\Delta T})\Delta T$$  \hspace{1cm} (6)

Analogous to Fourier’s law $Q = K\Delta T$, the effective thermal conductance of TEC is defined in Eq. (6) as follows [19]

$$K_{\text{TEC}}^{\text{Eff}} = K_{\text{Device}} + \frac{(S_{\text{TEC}}T_{\text{Heat}})^2}{2R_{\text{TEC}}\Delta T}$$  \hspace{1cm} (7)

which includes the passive thermal conductance by the Fourier conduction ($K_{\text{Device}}$) and active thermal conductance by the Peltier effect ($\frac{(S_{\text{TEC}}T_{\text{Heat}})^2}{2R_{\text{TEC}}\Delta T}$). By applying experimentally quantified parameter values, $K_{\text{TEC}}^{\text{Eff}}$ of the (F-)TEC samples were determined and compared at $\Delta T = 100$ K (Fig. 4). $K_{\text{TEC}}^{\text{Eff}}$ monotonically increases as $K_{\text{Device}}$ increases owing to the additional contribution of the filler. Accordingly, the BN33 sample exhibits a 42.5% larger $K_{\text{TEC}}^{\text{Eff}}$ (21.86 mW/K) compared to the Bare sample ($K_{\text{TEC}}^{\text{Eff}} = 15.34$ mW/K), which corresponds to the previous observation in hotspot cooling (Fig. 3b).
Fig. 4. (a) Effective thermal conductance of the samples $K_{TEC}^{Eff}$ calculated based on $T_{Heat} = 400 \text{ K}$ and $T_{Sink} = 300 \text{ K}$ and passive thermal conductance $K_{Device}$. The vertical dashes lines correspond to $K_{Device}$ of the experimental samples. (b) Comparison of $K_{TEC}^{Eff}$ between Bare and BN33.

3.5 Visualization of the temperature gradient using an IR camera

Considering the TE fill factor of ~0.24 of the Bare sample, the TE legs experienced a large heat flux exceeding 234 000 W/m² and longitudinal temperature gradient $\nabla T$ exceeding 65.6 K/mm under the heat load condition $Q'' = 56 250 \text{ W/m}^2$ (Section 3.3). Such large $\nabla T$ applied to the TE legs may affect to the thermal stability of the TE legs and the lifespan of the TECs. We visualized the temperature profile of the TE legs under hotspot cooling using an IR camera (Image IR 7300, InfraTec). The technical details of IR imaging can be found in the authors’ previous papers [49,50]. In TECs, the $\nabla T$ is forming from individual contributions of (1) a linear temperature profile due to Fourier heat conduction and Peltier heat flow, and (2) a parabolic temperature profile due to current-induced volumetric Joule heating [19,33]. To investigate the $\nabla T$ generated by both effects, the temperature profile of TE legs was recorded by applying $Q'' = 46 500 \text{ W/m}^2$ to the heat-loaded side of TECs, and $I_p = 0$ and 1 A to the TECs (Fig. 5). The $Q''$ of 46 500 W/m² was the maximum value that could be applied for the IR experiment. Although it is smaller than that in the cooling performance evaluation, it still corresponds to the hotspot cooling case. Note that the Peltier, Fourier, and Joule heating effects
determined the longitudinal temperature profile, even though the TEC lost heat by natural air convection during the IR experiment.

Fig. 5. (a) Photograph and (e) Schematic illustration of experimental configurations for IR visualization. A heat flux of 46 500 W/m² was applied by the heater. Temperature contour of TEC (Bare) for (b) $I_p = 0$ A and (f) $I_p = 1$ A. Temperature contour of F-TEC (BN33) for (c) $I_p = 0$ A and (g) $I_p = 1$ A. The white lines are guides to the eye, indicating the boundaries of TE legs, filler, heat spreaders, and Cu block. Temperature profiles of the TEC and F-TEC for (d) $I_p = 0$ A and (g) $I_p = 1$ A following the line (L1) through a TE leg sandwiched between alumina heat spreaders.

The IR tests were conducted with the TEC (Bare) and F-TEC (BN33) samples, which were covered by a graphite spray for the uniform emissivity of their side faces (Fig. 5a). The IR signals of each pixel were recorded and subsequently converted to the corresponding temperatures using pre-calibrated data. For $I_p = 0$ A, only Fourier heat flowed through the configurations yielding almost uniform $\nabla T$ along the TE legs of the TEC and F-TEC (Figs. 5b and c). The corresponding temperature profiles along the longitudinal line (L1) from the heat-loaded side to the heat sink were almost linear in the TE legs (Fig. 5d), indicating that the longitudinal heat load and not air convection dominated the longitudinal temperature profile. The TE leg in the F-TEC exhibited a smaller temperature profile and $\nabla T$ than those in the TEC owing to the heat dissipation by filler. As a result, the heat-loaded side in F-TEC exhibited
lower temperature ($T_{\text{Heat}} \sim 348$ K) compared to TEC ($T_{\text{Heat}} \sim 354$ K), although the F-TEC experienced a larger heat load than the TEC because of larger thermal conductance. Based on simple calculation for the heat losses by air convection with natural heat transfer coefficient of 5–20 W/m² K [33], the F-TEC experienced 12–39% higher heat load than the TEC from the heater, which led to a conservative estimation of $\nabla T$ inside the F-TEC compared to the TEC. Next, $I_p = 1$ A was applied to both TECs with the same experimental conditions. The generated heat inside the TE legs by Joule heating is equal for the TEC and F-TEC unless different module properties exist. The Joule heat is partially dissipated from the legs to the gaps in between. In the case of the F-TEC, this dissipation is much higher owing to the higher thermal conductivity of the filler compared to air in TEC. Therefore, the TE legs in BN33 exhibited a smaller $\nabla T$ and maximum temperature of the legs ($T_{\text{Max Legs}} = 334.4$ K) in comparison with those of Bare ($T_{\text{Max Legs}} = 344.3$ K) (Fig. 5g). The temperature profiles in Fig. 5g confirm the parabolic temperature profile due to Joule heating with a maximum at the middle of the legs. The slight difference in temperature distribution between the TE legs (Figs. 5f and g) possibly resulted from the differences in (1) TE properties of n- and p-type materials such as $\sigma$, $S$, and $\kappa$ or (2) the heat transfer condition at the surfaces facing to air or filler. These results clearly implied that the embedded filler in the F-TECs reduced the $\nabla T$ along the TE legs.
4. Conclusion

We proposed a novel TEC device concept for hotspot cooling applications by embedding the interior of a commercial TEC with a thermally conductive and electrically insulating filler material. The filler improves the integral thermal device conductance $K_{\text{Device}}$ of the F-TEC, which is an important parameter for hotspot cooling, by opening a new heat conduction path next to the conduction through the TE legs. In this way, the proposed F-TEC can overcome the engineering challenges at the material level that are caused by the interdependence among the TE parameters, which impedes the individual adjustment of thermal and thermoelectric transport properties. Consequently, the relatively easy application of a thermally conductive filler material provides an additional degree of freedom to the system design. Embedding a filler into a TEC enables the independent control of Fourier heat conduction without any influence on the Peltier-driven heat transport. The F-TECs were experimentally demonstrated using various Ecoflex–BN composite fillers, with which $K_{\text{Device}}$ was systematically controlled at 300 K in the range of 5.15–11.67 mW/K (127% change). The cooling performances of the F-TECs improved owing to the fillers; the hotspot temperature under the heat flux $Q''=56$ 250 W/m$^2$ decreased from 431.2 K (Bare) to 364.6 K (BN33) at $I_P=0$ and 331.6 K to 316.8 K at $I_P=1$ A. The effective thermal conductance ($K_{\text{Device}}^{\text{eff}}$) was used to evaluate the heat-dissipation efficiency of TECs. The BN33 sample exhibited 42.5% higher $K_{\text{Device}}^{\text{eff}}$ than Bare at $\Delta T=100$ K. Moreover, IR imaging revealed that the filler can decrease the maximum temperature and $VT$ in the TE legs. We envision that the proposed F-TEC concept can assist the development of an effective TEC device that can be widely used for hotspot cooling applications, such as in microprocessors, fuel cells, photovoltaic cells and batteries.

Although the cooling performance of the F-TECs was evaluated under heat load of 5.6 W/cm$^2$, smaller than that of practical hotspot cooling applications (e.g., 100 W/cm$^2$ for microprocessor), we expect further improvements by optimizing material properties and structural designs. Accordingly, we present considerations to improve the proposed F-TEC according to the following aspects. First, using high-$\kappa$ filler materials can largely improve the cooling efficiency of an F-TEC for hotspot cooling, although we employed polymer–ceramic composites with relatively low $\kappa$ in this study to exclude other technological challenges, such as matching the thermal expansion coefficients and suppressing electrical interferences.
between the TE legs and filler material. As the heat dissipation in an F-TEC is primarily unidirectional from the heat-loaded side to the heat sink (i.e. longitudinal), thermally anisotropic materials, such as transition metal dichalcogenides [51,52], hexagonal BN [53], and graphene [54], may be useful. Furthermore, the fillers are not limited to solid materials; highly thermally conductive liquid metals [55,56] could be considered fillers if outer surfaces of legs and bridges were electrically insulated by application of suitable layers. Second, the thermal expansion coefficient of the filler should be matched with those of the TE materials to reduce the thermomechanical stress in the TE legs [13,16,57], although this did not cause a significant problem in this study when using an elastic polymer composite filler. Third, the filler factor can be used as a design parameter to control the fractions of the Peltier and Fourier heat transfer, which mainly dissipate heat through the TE legs and filler, respectively. Fourth, although an F-TEC possess better cooling performance than a classical TEC, it requires more material and thus leads to increase in the device cost. Analyzing the thermoelectric operating cost (in units of $/kWh) may help to optimize the trade-off relation between the cooling performance and device cost [58]. Lastly, introducing thermal diodes may facilitate the development of a universal TEC that could be applicable for hotspot cooling, refrigeration, and under intermediate conditions. In addition to filler engineering, we emphasize the development of TE hotspot cooling materials with high $\kappa$ and large PF [18–21,59]. By incorporating such materials and the F-TEC concept proposed in this study, the simultaneous optimization of PF and $K_{Device}$, and accordingly further performance improvement are expected.
CRediT authorship contribution statement

Sang J. Park: Conceptualization, Data curation, Formal analysis, Investigation, Methodology, Software, Validation, Visualization, Writing - Original Draft, Writing - Review & Editing.

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Declaration of competing interest

The authors declare no competing financial interest.

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Appendix A. Supplementary Information

Supplementary Information associated with this article can be found, in the online version, at [DOI].
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